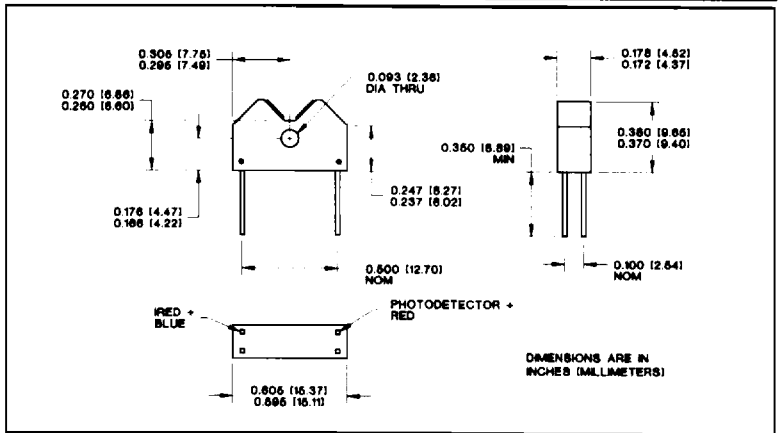
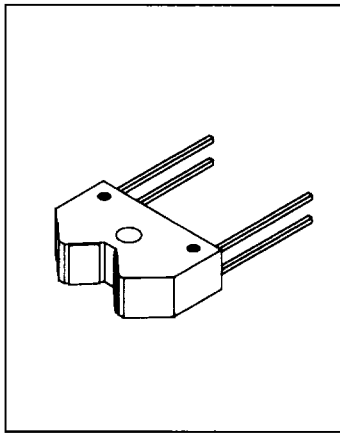


R-310 Series

Wafer Scanner® Reflective Optical Switch



Features

- detects semiconductor wafers
- operating distance 0.050" (1.27mm)
- small physical size
- three body styles
- wavelength-filtered sensor

Description

The R-310 series consists of a gallium arsenide IRED and a silicon photosensor mounted in an injection-molded housing. The R-310, 312, and 314 feature phototransistors; the R-311, 313, and 315 have photodarlingtons. The unit directs energy from the IRED to the target; reflected energy is transmitted through an ambient light filter to the photosensor. Peak response is at 910 nm but is filtered -26 dB at 750 nm and -60 dB at 700 nm and below. See the part number guide on next page for ordering information.

Absolute Maximum Ratings ($T_A = 25^\circ\text{C}$ unless otherwise stated.)

Storage and Operating Temperature -40°C to $+50^\circ\text{C}$
 Lead Soldering Temperature⁽¹⁾ 240°C ⁽²⁾

IRED

Continuous Forward Current 40mA
 Peak Forward Current (1 μs pulse width, 300pps) 2A
 Reverse Voltage 3V
 Power Dissipation 70mW ⁽³⁾

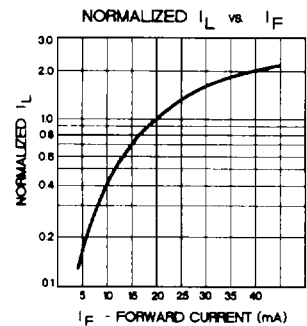
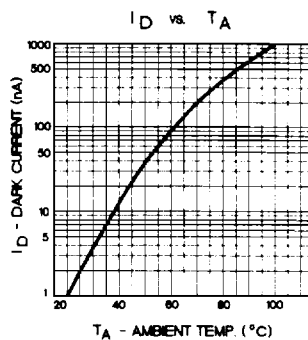
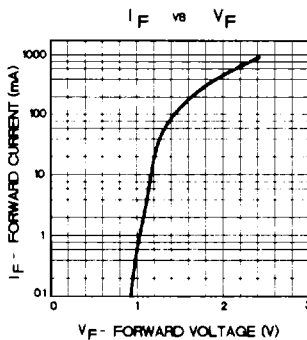
Sensor

Collector-Emitter Voltage 30V
 Emitter-Collector Voltage 5V
 Power Dissipation 70mW ⁽³⁾

Notes:

1. 0.06" (1.5mm) from the case for 5 seconds maximum. (device leads)
2. 260°C maximum when wave soldering. (device leads)
3. Derate linearly from 25°C to $T_A = 50^\circ\text{C}$ at $-1.70\text{ mW}/^\circ\text{C}$.

Fundamental Characteristics



OptoSwitch • 1500 International Parkway, Suite 100 • Richardson, Texas 75081 • Phone: 214-479-1122 • 800-448-2900
 CLAROSTAT Sensors and Controls

R-310 Series

Wafer Scanner Reflective Optical Switch



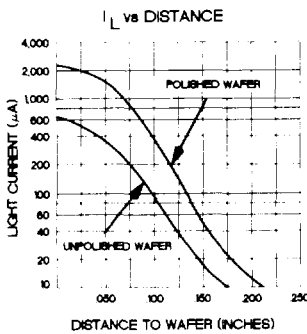
Electrical Characteristics ($T_A = 25^\circ\text{C}$ unless otherwise stated)

Symbol	Parameter	min	max	units	Test Conditions
Input Diode					
V_F	Forward Voltage	1.10	1.70	V	$I_F = 60\text{mA}$
I_R	Reverse Current	-	100	μA	$V_R = 2.0\text{V}$
Output Phototransistor⁽¹⁾					
$V_{(BR)CEO}$	Collector-Emitter Breakdown Voltage	30	-	V	$I_C = 1\text{mA}$
$V_{(BR)ECO}$	Emitter-Collector Breakdown Voltage	5.0	-	V	$I_E = 100\mu\text{A}$
I_D	Dark Current	-	100	nA	$V_{CE} = 10\text{V}, E_b = 0$
Coupled					
I_L	Light Current ^{(2) (3)}				
	R-310, 312, and 314	0.25	-	mA	$I_F = 40\text{mA}, V_{CE} = 5\text{V}, d = 0.050''$
	R-311, 313, and 315	2.0	-	mA	$I_F = 40\text{mA}, V_{CE} = 5\text{V}, d = 0.050''$

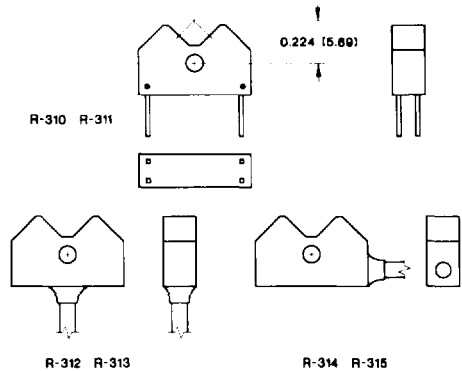
Notes:

1. Radiation outside the sensitivity range of the device may be present during these measurements. Sufficient protection has been provided when the parameter being measured cannot be altered by further irradiation shielding.
2. Other ranges of light current can be specified; call Clarostat for applications assistance.
3. 'd' is the distance from the most forward point of the skanner to a Kodak 90% diffuse reflectance neutral test card; for all testing, $d = 0.050''$ (1.27mm).

Typical Characteristics



Part Number Guide



- R-310 R-311 FOUR TINNED LEADS FOR CIRCUIT BOARD MOUNTING
- R-312 R-313 4 COND. 28 GA. TEFLON COVERED CABLE WITH SHIELDED PHOTODETECTOR LEADS AND OVERALL SHIELD, 2 FT. LONG, TYPE J (SHIELDED QUAD)
- R-314 R-315